Search Notes

Application/Control No	. Applicant(s)/Patent under Reexamination	
09/802,577	BEAVEN ET AL.	
Examiner	Art Unit	
Kieu D. Vu	2173	

SEAR Subclass	CHED Date	
Subclass	Date	
	Date	Examiner
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East search (USPAT USPGPUB EPO JPO DERWENT IBM_TDB USOCR) (See Search History Printout)	6/7/2006	κv		